

Zbigniew Mitura

List of Publications by Year in descending order

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39
papers

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citing authors

| # | ARTICLE | IF | CITATIONS |
|----|---|-----|-----------|
| 1 | Simplified Determination of RHEED Patterns and Its Explanation Shown with the Use of 3D Computer Graphics. <i>Materials</i> , 2021, 14, 3056. | 2.9 | 5 |
| 2 | An Analysis of Kikuchi Lines Observed with a RHEED Apparatus for a TiO ₂ -Terminated SrTiO ₃ (001) Crystal. <i>Materials</i> , 2021, 14, 7077. | 2.9 | 5 |
| 3 | Comparison of azimuthal plots for reflection high-energy positron diffraction (RHEPD) and reflection high-energy electron diffraction (RHEED) for Si(111) surface. <i>Acta Crystallographica Section A: Foundations and Advances</i> , 2020, 76, 328-333. | 0.1 | 3 |
| 4 | Discussion of the importance of the refraction effects for RHEED. <i>Applied Surface Science</i> , 2017, 421, 247-251. | 6.1 | 0 |
| 5 | Calculations of RHEED and RHEPD Rocking Curves for Growing Surfaces of Germanium. <i>Acta Physica Polonica A</i> , 2016, 130, 1134-1136. | 0.5 | 0 |
| 6 | Algorithms for determining the phase of RHEED oscillations. <i>Journal of Applied Crystallography</i> , 2015, 48, 1927-1934. | 4.5 | 5 |
| 7 | Theoretical analysis of reflection high-energy electron diffraction (RHEED) and reflection high-energy positron diffraction (RHEPD) intensity oscillations expected for the perfect layer-by-layer growth. <i>Acta Crystallographica Section A: Foundations and Advances</i> , 2015, 71, 513-518. | 0.1 | 2 |
| 8 | Calculations of parameters of RHEED oscillations using different models of the scattering potential. <i>Journal of Crystal Growth</i> , 2014, 401, 364-366. | 1.5 | 2 |
| 9 | Computer Investigations of Features of RHEED Oscillations for GaAs and for Ge. <i>Solid State Phenomena</i> , 2013, 203-204, 347-350. | 0.3 | 0 |
| 10 | Computer studies on reflection high-energy electron diffraction from the growing surface of Ge(001). <i>Journal of Applied Crystallography</i> , 2013, 46, 1024-1030. | 4.5 | 3 |
| 11 | Thixoforming of spray formed M2 tool steel. <i>International Journal of Material Forming</i> , 2010, 3, 755-758. | 2.0 | 9 |
| 12 | Microstructure evolution in hot worked steel after heating to semi-solid state. <i>Journal of Microscopy</i> , 2010, 237, 469-474. | 1.8 | 2 |
| 13 | Thixoforming technology of high carbon X210CrW12 steel. <i>International Journal of Material Forming</i> , 2009, 2, 753-756. | 2.0 | 12 |
| 14 | Investigation of Si/Au vicinal surfaces using scanning tunnelling microscopy and reflection high-energy electron diffraction. <i>Journal of Microscopy</i> , 2006, 224, 125-127. | 1.8 | 0 |
| 15 | Modelling thixocasting with precise accounting of moving front of material. <i>Materials Science and Technology</i> , 2005, 21, 551-558. | 1.6 | 7 |
| 16 | The small terrace size approximation in the theory of RHEED oscillations. <i>Journal of Crystal Growth</i> , 2002, 235, 79-88. | 1.5 | 9 |
| 17 | Iterative method of calculating reflection-high-energy-electron-diffraction intensities. <i>Physical Review B</i> , 1999, 59, 4642-4645. | 3.2 | 6 |
| 18 | RHEED FROM EPITAXIALLY GROWN THIN FILMS. <i>Surface Review and Letters</i> , 1999, 06, 497-516. | 1.1 | 11 |

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|----|--|-----|-----------|
| 19 | Interpretation of reflection high-energy electron diffraction oscillation phase. <i>Journal of Crystal Growth</i> , 1999, 198-199, 905-910. | 1.5 | 11 |
| 20 | Theoretical Analysis of RHEED Intensities for Growing Surfaces. <i>Surface Review and Letters</i> , 1998, 05, 701-709. | 1.1 | 7 |
| 21 | Phase of RHEED oscillations. <i>Physical Review B</i> , 1998, 57, 6309-6312. | 3.2 | 23 |
| 22 | In situ characterization of epitaxially grown thin layers. <i>Physical Review B</i> , 1996, 53, 10200-10208. | 3.2 | 11 |
| 23 | Theoretical studies on the quantitative interpretation of RHEED data. <i>Journal of Physics Condensed Matter</i> , 1996, 8, 8717-8731. | 1.8 | 4 |
| 24 | Direct observation of rare-earth silicide epilayer formation by RHEED technique. <i>Vacuum</i> , 1995, 46, 531-535. | 3.5 | 2 |
| 25 | Investigation of a new method to control thin-film growth. <i>Applied Physics A: Materials Science and Processing</i> , 1995, 60, 227-231. | 2.3 | 11 |
| 26 | RHEED intensity oscillations during the growth of Pb _{1-x} In films on Si(111) with modified surface. <i>Vacuum</i> , 1994, 45, 303-305. | 3.5 | 0 |
| 27 | RHEED oscillations at special diffraction conditions. <i>Surface Science</i> , 1993, 298, 293-298. | 1.9 | 6 |
| 28 | Analysis of reflection high energy electron diffraction azimuthal plots. <i>Physical Review Letters</i> , 1993, 70, 2904-2907. | 7.8 | 37 |
| 29 | Studies on RHEED oscillations at low glancing angles. <i>Surface Science</i> , 1992, 277, 229-233. | 1.9 | 29 |
| 30 | RHEED intensity oscillations with extra maxima. <i>Surface Science</i> , 1992, 276, L15-L18. | 1.9 | 22 |
| 31 | Analysis of Shapes of RHEED Intensity Oscillations Observed for Growing Films. <i>Acta Physica Polonica A</i> , 1991, 80, 365-368. | 0.5 | 5 |
| 32 | Computer study of the influence of thermal vibrations on the RHEED intensity. <i>Physics Letters, Section A: General, Atomic and Solid State Physics</i> , 1990, 150, 51-52. | 2.1 | 6 |
| 33 | Ion beam mixing in Au-Cu compositionally modulated alloys. <i>Materials Letters</i> , 1990, 9, 325-328. | 2.6 | 3 |
| 34 | A study of the Ag/Cu and Au/Cu interfaces. <i>Surface Science</i> , 1990, 231, 90-94. | 1.9 | 11 |
| 35 | Structure properties of Pd/V superlattices formed by the dual electron-beam system. <i>Surface Science</i> , 1990, 231, 188-192. | 1.9 | 1 |
| 36 | Growth of the Bi-Sb superlattice. <i>Journal of Physics Condensed Matter</i> , 1989, 1, 7795-7800. | 1.8 | 6 |

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|----|---|-----|-----------|
| 37 | Rheed intensity calculations for Au(001) ultrathin films on an Ag(001) substrate and for an Au/Ag(001) superlattice. Surface Science, 1989, 222, 247-258. | 1.9 | 3 |
| 38 | Computer simulation of X-ray spectra of metallic superlattices. Journal of Physics F: Metal Physics, 1988, 18, 183-195. | 1.6 | 33 |
| 39 | The Use of ADINA Software to Simulate Thixocasting Processes. Solid State Phenomena, 0, , 626-629. | 0.3 | 0 |